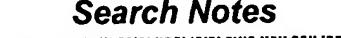


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/018,520	HAWKER, PELHAM NIGEL
	Examiner	Art Unit
	Hien Tran	1764

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner